

Application/Control No.	Applicant(s)/Patent under Reexamination
10/620,284	PACK ET AL.
Examiner	Art Unit
Binh C. Tat	2825

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	SEAR	CHED	
Class	Subclass	Date	Examiner
716	19-21	4/16/2005	ВТ
430	5,22,30	4/16/2005	ВТ
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date .	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST SEARCH	4/16/2005	ВТ	
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